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## SN74CB3Q3384A 10-BIT FET BUS SWITCH 2.5-V/3.3-V LOW-VOLTAGE HIGH-BANDWIDTH BUS SWITCH

SCDS114D-DECEMBER 2002-REVISED JUNE 2005

#### **FEATURES**

- High-Bandwidth Data Path (up to 500 MHz <sup>(1)</sup>)
- 5-V Tolerant I/Os With Device Powered Up or Powered Down
- Low and Flat ON-State Resistance (r<sub>on</sub>) Characteristics Over Operating Range (r<sub>on</sub> = 3 Ω Typ)
- Rail-to-Rail Switching on Data I/O Ports
  - 0- to 5-V Switching With 3.3-V V<sub>CC</sub>
  - 0- to 3.3-V Switching With 2.5-V V<sub>CC</sub>
- Bidirectional Data Flow With Near-Zero Propagation Delay
- Low Input/Output Capacitance Minimizes
   Loading and Signal Distortion
   (C<sub>io(OFF)</sub> = 4 pF Typ)
- Fast Switching Frequency (f<sub>OE</sub> = 20 MHz Max)
- (1) For additional information regarding the performance characteristics of the CB3Q family, refer to the TI application report, CBT-C, CB3T, and CB3Q Signal-Switch Families, literature number SCDA008.

- Data and Control Inputs Provide Undershoot Clamp Diodes
- Low Power Consumption (I<sub>CC</sub> = 1 mA Typ)
- V<sub>CC</sub> Operating Range From 2.3 V to 3.6 V
- Data I/Os Support 0- to 5-V Signaling Levels (0.8 V, 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V, 5 V)
- Control Inputs Can Be Driven by TTL or 5-V/3.3-V CMOS Outputs
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78. Class II
- ESD Performance Tested Per JESD 22
  - 2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)
- Supports Both Digital and Analog Applications: PCI Interface, Differential Signal Interface, Memory Interleaving, Bus Isolation, Low-Distortion Signal Gating

# DBQ, DGV, OR PW PACKAGE (TOP VIEW)

1OE [ 1B1 [ 1A1 [ 1A2 [ 1B3 [ 1A3 [ 1A4 [ 1B4 [ 1B5 [ 1A5 [	1 2 3 4 5 6 7 8 9 10	U	24 23 22 21 20 19 18 17 16 15 14	V <sub>CC</sub> 2B5 2A5 2A4 2B4 2B3 2A3 2A2 2B2 2B1 2B1
1A5 [ GND [	∃ ``		-	<b>F</b>
J.,D [	Ľ		. •	٦-٥-

#### DESCRIPTION/ORDERING INFORMATION

#### ORDERING INFORMATION

T <sub>A</sub>	PACK	AGE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	QSOP – DBQ	Tape and reel	SN74CB3Q3384ADBQR	CB3Q3384A	
–40°C to 85°C	TCCOD DW	Tube	SN74CB3Q3384APW	BU384A	
-40 C to 65 C	TSSOP – PW	Tape and reel	SN74CB3Q3384APWR		
	TVSOP - DGV	Tape and reel	SN74CB3Q3384ADGVR	BU384A	

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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## **DESCRIPTION/ORDERING INFORMATION (CONTINUED)**

The SN74CB3Q3384A is a high-bandwidth FET bus switch utilizing a charge pump to elevate the gate voltage of the pass transistor, providing a low and flat ON-state resistance  $(r_{on})$ . The low and flat ON-state resistance allows for minimal propagation delay and supports rail-to-rail switching on the data input/output (I/O) ports. The device also features low data I/O capacitance to minimize capacitive loading and signal distortion on the data bus. Specifically designed to support high-bandwidth applications, the SN74CB3Q3384A provides an optimized interface solution ideally suited for broadband communications, networking, and data-intensive computing systems.

The SN74CB3Q3384A is organized as two 5-bit bus switches with separate output-enable ( $1\overline{OE}$ ,  $2\overline{OE}$ ) inputs. It can be used as two 5-bit bus switches or as one 10-bit bus switch. When  $\overline{OE}$  is low, the associated 5-bit bus switch is ON, and the A port is connected to the B port, allowing bidirectional data flow between ports. When  $\overline{OE}$  is high, the associated 5-bit bus switch is OFF, and a high-impedance state exists between the A and B ports.

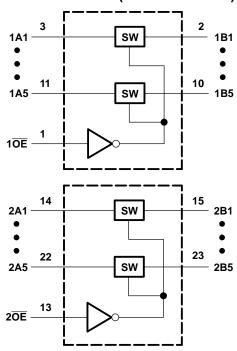
This device is fully specified for partial-power-down applications using  $I_{\text{off}}$ . The  $I_{\text{off}}$  circuitry prevents damaging current backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

# FUNCTION TABLE (EACH 5-BIT BUS SWITCH)

INPUT OE	INPUT/OUTPUT A	FUNCTION
L	В	A port = B port
Н	Z	Disconnect

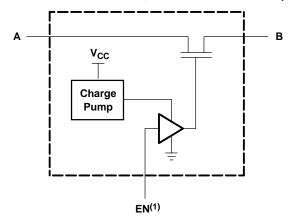
#### **LOGIC DIAGRAM (POSITIVE LOGIC)**





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### SIMPLIFIED SCHEMATIC, EACH FET SWITCH (SW)



(1) EN is the internal enable signal applied to the switch.

## **Absolute Maximum Ratings**(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	4.6	V
V <sub>IN</sub>	Control input voltage range <sup>(2)(3)</sup>		-0.5	7	V
V <sub>I/O</sub>	Switch I/O voltage range <sup>(2)(3)(4)</sup>		-0.5	7	V
I <sub>IK</sub>	Control input clamp current	V <sub>IN</sub> < 0		-50	mA
I <sub>I/OK</sub>	I/O port clamp current	V <sub>I/O</sub> < 0		-50	mA
I <sub>I/O</sub>	ON-state switch current <sup>(5)</sup>			±64	mA
lo	Continuous current through V <sub>CC</sub> or GND			±100	mA
		DBQ package		61	
$\theta_{JA}$	Package thermal impedance (6)	DGV package		86	°C/W
		PW package		88	
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# Recommended Operating Conditions<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage		2.3	3.6	V
\/	High level control input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V	1.7	5.5	V
$V_{IH}$	High-level control input voltage	V <sub>CC</sub> = 2.7 V to 3.6 V	2	5.5	V
	Lave laved appetral insert values	V <sub>CC</sub> = 2.3 V to 2.7 V		0.7	
$V_{IL}$	Low-level control input voltage	0	0.8	V	
V <sub>I/O</sub>	Data input/output voltage		0	5.5	V
T <sub>A</sub>	Operating free-air temperature		-40	85	°C

<sup>(1)</sup> All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

<sup>(2)</sup> All voltages are with respect to ground, unless otherwise specified.

<sup>(3)</sup> The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>(4)</sup> V<sub>I</sub> and V<sub>O</sub> are used to denote specific conditions for V<sub>I/O</sub>.

<sup>(5)</sup>  $I_1$  and  $I_0$  are used to denote specific conditions for  $I_{1/0}$ .

<sup>(6)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.

## **SN74CB3Q3384A 10-BIT FET BUS SWITCH** 2.5-V/3.3-V LOW-VOLTAGE HIGH-BANDWIDTH BUS SWITCH



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## Electrical Characteristics(1)

over recommended operating free-air temperature range (unless otherwise noted)

PA	RAMETER		TEST CONDITIO	NS	MIN TYP <sup>(2)</sup> MAX		MAX	UNIT
$V_{IK}$		$V_{CC} = 3.6 \text{ V},$	$I_I = -18 \text{ mA}$				-1.8	V
I <sub>IN</sub>	Control inputs	V <sub>CC</sub> = 3.6 V,	V <sub>IN</sub> = 0 to 5.5 V				±1	μΑ
I <sub>OZ</sub> (3)		V <sub>CC</sub> = 3.6 V,	$V_{O} = 0 \text{ to } 5.5 \text{ V},$ $V_{I} = 0,$	Switch OFF, V <sub>IN</sub> = V <sub>CC</sub> or GND			±1	μΑ
I <sub>off</sub>		$V_{CC} = 0$ ,	$V_0 = 0 \text{ to } 5.5 \text{ V},$	$V_I = 0$			1	μΑ
I <sub>CC</sub>		V <sub>CC</sub> = 3.6 V,	$I_{I/O} = 0$ , Switch ON or OFF,	$V_{IN} = V_{CC}$ or GND		1	2	mA
$\Delta I_{CC}^{(4)}$	Control inputs	$V_{CC} = 3.6 \text{ V},$	One input at 3 V,	Other inputs at V <sub>CC</sub> or GND			30	μΑ
. (5)	Per control input	V <sub>CC</sub> = 3.6 V,	A and B ports open,		0.15	0.25	mA/	
I <sub>CCD</sub> <sup>(5)</sup>		Control input switching at 50% duty cycle				0.15	0.25	MHz
C <sub>in</sub>	Control inputs	$V_{CC} = 3.3 \text{ V},$	V <sub>IN</sub> = 5.5 V, 3.3 V, or	0		2.5	3.5	pF
C <sub>io(OFF)</sub>		V <sub>CC</sub> = 3.3 V,	Switch OFF, V <sub>IN</sub> = V <sub>CC</sub> or GND,	V <sub>I/O</sub> = 5.5 V, 3.3 V, or 0		3.5	5	pF
C <sub>io(ON)</sub>		V <sub>CC</sub> = 3.3 V,	Switch ON, $V_{IN} = V_{CC}$ or GND,	$V_{I/O} = 5.5 \text{ V}, 3.3 \text{ V}, \text{ or } 0$		8	10	pF
		V <sub>CC</sub> = 2.3 V,	$V_{I} = 0,$	I <sub>O</sub> = 30 mA		3	8	
r (6)		TYP at $V_{CC} = 2.5 \text{ V}$	$V_{I} = 1.7 \text{ V},$ $I_{O} = -15 \text{ mA}$			3.5	9	0
r <sub>on</sub> <sup>(6)</sup>		V - 2 V	$V_{I} = 0$ ,	I <sub>O</sub> = 30 mA		3	6	Ω
		$V_{CC} = 3 V$	$V_1 = 2.4 V,$	$I_O = -15 \text{ mA}$		3.5	8	

- $V_{IN}$  and  $I_{IN}$  refer to control inputs.  $V_I$ ,  $V_O$ ,  $I_I$ , and  $I_O$  refer to data pins. All typical values are at  $V_{CC}=3.3~V$  (unless otherwise noted),  $T_A=25^{\circ}C$ . For I/O ports, the parameter  $I_{OZ}$  includes the input leakage current.
- This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.
- This parameter specifies the dynamic power-supply current associated with the operating frequency of a single control input (see Figure 2).
- Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

#### **Switching Characteristics**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 1 ± 0.2	2.5 V 2 V	V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
	(INPOT)	(001701)	MIN	MAX	MIN	MAX	
f <sub>OE</sub> <sup>(1)</sup>	ŌĒ	A or B		10		20	MHz
t <sub>pd</sub> (2)	A or B	B or A		0.09		0.15	ns
t <sub>en</sub>	ŌĒ	A or B	1.5	7.2	1.5	6	ns
t <sub>dis</sub>	ŌE	A or B	1.5	6.6	1.5	6.6	ns

<sup>(1)</sup> Maximum switching frequency for control input ( $V_O > V_{CC}$ ,  $V_I = 5$  V,  $R_L \ge 1$  M $\Omega$ ,  $C_L = 0$ )
(2) The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).



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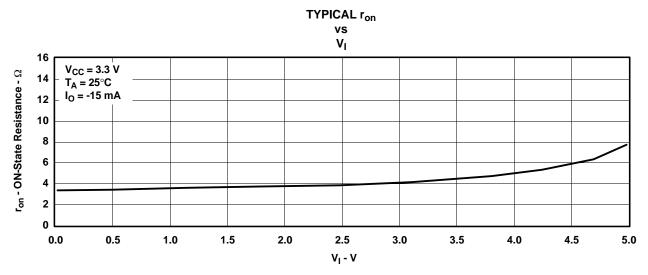


Figure 1. Typical ron vs VI

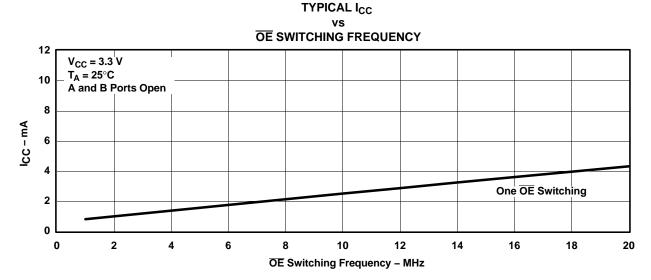
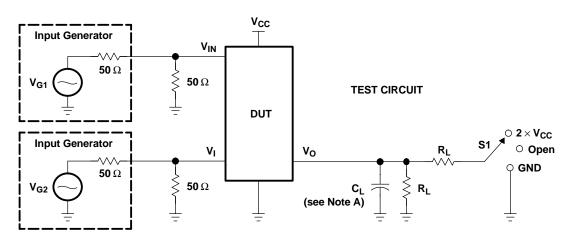


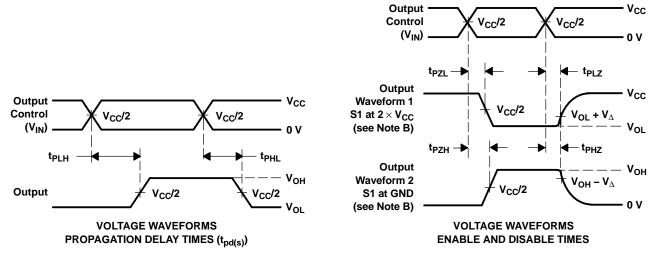
Figure 2. Typical I<sub>CC</sub> vs  $\overline{OE}$  Switching Frequency



#### PARAMETER MEASUREMENT INFORMATION



TEST	V <sub>CC</sub>	S1	R <sub>L</sub>	VI	CL	$V_{\Delta}$
t <sub>pd(s)</sub>	2.5 V $\pm$ 0.2 V	Open	500 Ω	V <sub>CC</sub> or GND	30 pF	
-pu(s)	3.3 V $\pm$ 0.3 V	Open	<b>500</b> Ω	V <sub>CC</sub> or GND	50 pF	
t <sub>PLZ</sub> /t <sub>PZL</sub>	2.5 V ± 0.2 V	2×V <sub>CC</sub>	500 Ω	GND	30 pF	0.15 V
'PLZ''PZL	3.3 V $\pm$ 0.3 V	2×V <sub>CC</sub>	500 Ω	GND	50 pF	0.3 V
4 /4	2.5 V ± 0.2 V	GND	500 Ω	V <sub>CC</sub>	30 pF	0.15 V
t <sub>PHZ</sub> /t <sub>PZH</sub>	3.3 V $\pm$ 0.3 V	GND	500 Ω	V <sub>CC</sub>	50 pF	0.3 V



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_Q = 50 \Omega$ ,  $t_f \leq$  2.5 ns.  $t_f \leq$  2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd(s)}$ . The  $t_{pd}$  propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
- H. All parameters and waveforms are not applicable to all devices.

Figure 3. Test Circuit and Voltage Waveforms

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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
74CB3Q3384ADGVRG4	Active	Production	TVSOP (DGV)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BU384A
74CB3Q3384ADGVRG4.B	Active	Production	TVSOP (DGV)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BU384A
SN74CB3Q3384ADBQR	Active	Production	SSOP (DBQ)   24	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	CB3Q3384A
SN74CB3Q3384ADBQR.A	Active	Production	SSOP (DBQ)   24	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	CB3Q3384A
SN74CB3Q3384ADBQR.B	Active	Production	SSOP (DBQ)   24	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	CB3Q3384A
SN74CB3Q3384ADGVR	Active	Production	TVSOP (DGV)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BU384A
SN74CB3Q3384ADGVR.B	Active	Production	TVSOP (DGV)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BU384A
SN74CB3Q3384APW	Obsolete	Production	TSSOP (PW)   24	-	-	Call TI	Call TI	-40 to 85	BU384A
SN74CB3Q3384APWR	Active	Production	TSSOP (PW)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BU384A
SN74CB3Q3384APWR.A	Active	Production	TSSOP (PW)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BU384A
SN74CB3Q3384APWR.B	Active	Production	TSSOP (PW)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BU384A

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



## **PACKAGE OPTION ADDENDUM**

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# **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
74CB3Q3384ADGVRG4	TVSOP	DGV	24	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74CB3Q3384ADBQR	SSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74CB3Q3384ADGVR	TVSOP	DGV	24	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74CB3Q3384APWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1



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#### \*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)			
74CB3Q3384ADGVRG4	TVSOP	DGV	24	2000	353.0	353.0	32.0			
SN74CB3Q3384ADBQR	SSOP	DBQ	24	2500	353.0	353.0	32.0			
SN74CB3Q3384ADGVR	TVSOP	DGV	24	2000	353.0	353.0	32.0			
SN74CB3Q3384APWR	TSSOP	PW	24	2000	353.0	353.0	32.0			

DBQ (R-PDSO-G24)

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AE.







#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

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NOTES: (continued)

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- 9. Board assembly site may have different recommendations for stencil design.



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